

PATENT  
450104-05892

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Applicants: Mitsuhiro SHIKIDA et al.

International Application No.: PCT/JP2005/000633

International Filing Date: January 13, 2005

For: CHEMICAL ANALYTIC APPARATUS AND  
CHEMICAL ANALYTIC METHOD

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Sir:

Enclosed are copies of the publications, which were cited in the International Search Report of International Application No. PCT/JP2005/000633. Also enclosed is a copy of Form PTO-1449 and the International Search Report.

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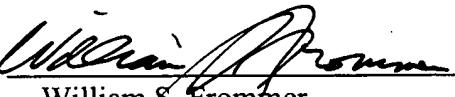
REMARKS

Entry of this Information Disclosure Statement and an early examination on the merits  
are respectfully solicited.

Please charge any additional fees to Deposit Account No. 50-0320.

Respectfully submitted,

FROMMER LAWRENCE & HAUG LLP  
Attorneys for Applicants

By:   
William S. Frommer  
Reg. No. 25,506  
Tel. (212) 588-0800

Enclosures

AP20 Rec'd PCT/PTO 14 JUL 2006

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| Based on Form PTO-1449<br>(3/90)   |  | ATTY. DOCKET NO.<br>450104-05892      | INT'L APPN. NO.<br>PCT/JP2005/000635<br><b>107586165</b> |
| LIST OF REFERENCES CITED BY APPLICANT<br>(Use several sheets if necessary) |  | APPLICANT<br>Mitsuhiko SHIKIDA et al. |  |
|  |  | INT'L FILING DATE<br>January 13, 2005 | GROUP<br>Unknown   |

| U.S. PATENT DOCUMENTS |    |                 |          |                 |       |          |                            |
|-----------------------|----|-----------------|----------|-----------------|-------|----------|----------------------------|
| EXAMINER INITIAL      |    | DOCUMENT NUMBER | DATE     | NAME            | CLASS | SUBCLASS | FILING DATE IF APPROPRIATE |
|                       | AA | 2004 0134854    | 07/15/04 | Higuchi et al.  |       |          |                            |
|                       | AB | 2003 0026705    | 02/06/03 | Ishiguro et al. |       |          |                            |
|                       | AC |                 |          |                 |       |          |                            |
|                       | AD |                 |          |                 |       |          |                            |
|                       | AE |                 |          |                 |       |          |                            |

## FOREIGN PATENT DOCUMENTS

| EXAMINER INITIAL |    | DOCUMENT NUMBER | DATE     | COUNTRY | CLASS | SUBCLASS | TRANSLATION YES NO |
|------------------|----|-----------------|----------|---------|-------|----------|--------------------|
|                  | AF | WO 02 066992    | 08/29/02 | PCT     |       |          |                    |
|                  | AG | EP 1 371 989    | 12/17/03 | Europe  |       |          |                    |
|                  | AH | 2003 50245      | 02/21/03 | Japan   |       |          |                    |
|                  | AI | EP 1 270 066    | 01/02/03 | Europe  |       |          |                    |
|                  | AJ | WO 03 026798    | 04/03/03 | PCT     |       |          |                    |
|                  | AK | 2005 503572     | 02/03/05 | Japan   |       |          |                    |
|                  | AL | 2003 169661     | 06/17/03 | Japan   |       |          |                    |
|                  | AM | WO 02 087764    | 11/07/02 | PCT     |       |          |                    |
|                  | AN | 2004 535916     | 12/02/04 | Japan   |       |          |                    |
|                  | AO | 8 178931        | 07/12/96 | Japan   |       |          |                    |
|                  | AP |                 |          |         |       |          |                    |

## OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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